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Details

Product Status	Active
Core Processor	S08
Core Size	8-Bit
Speed	16MHz
Connectivity	-
Peripherals	LVD, POR, PWM, WDT
Number of I/O	4
Program Memory Size	2KB (2K x 8)
Program Memory Type	FLASH
EEPROM Size	•
RAM Size	128 x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 4x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	8-SOIC (0.154", 3.90mm Width)
Supplier Device Package	8-SOIC
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mc9s08qd2mscr

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Chapter 2 External Signal Description

This chapter describes signals that connect to package pins. It includes pinout diagrams, table of signal properties, and detailed discussions of signals.

2.1 Device Pin Assignment

Figure 2-1 shows the pin assignments for the 8-pin packages.



Figure 2-1. 8-Pin Packages

2.2 Recommended System Connections

Figure 2-2 shows pin connections that are common to almost all MC9S08QD4 series application systems.



2.2.5.2 Output Slew Rate Control

Slew rate control can be enabled for each port pin by setting the corresponding bit in one of the slew rate control registers (PTxSEn). When enabled, slew control limits the rate at which an output can transition in order to reduce EMC emissions. Slew rate control has no effect on pins that are configured as inputs.

2.2.5.3 Output Drive Strength Select

An output pin can be selected to have high output drive strength by setting the corresponding bit in one of the drive strength select registers (PTxDSn). When high drive is selected, a pin is capable of sourcing and sinking greater current. Even though every I/O pin can be selected as high drive, the user must ensure that the total current source and sink limits for the chip are not exceeded. Drive strength selection is intended to affect the DC behavior of I/O pins. However, the AC behavior is also affected. High drive allows a pin to drive a greater load with the same switching speed as a low drive enabled pin into a smaller load. Because of this, the EMC emissions may be affected by enabling pins as high drive.

Lowes	st <- Pin Functio	on Priority -> Hi				
Port Pins	Port PinsAlternative FunctionAlternative FunctionAlternative Function		Alternative Function	Reference ¹		
PTA0 PTA1 PTA2 PTA3 PTA4 PTA5 ²	KBI1P0 KBI1P1 KBI1P2 KBI1P3 TPM2CH00 TPM2CH01	TPM1CH0 TPM1CH1 TCLK1 TCLK2 BKGD/MS IRQ	ADC1P0 ³ ADC1P1 ³ ADC1P2 ³ ADC1P3 ³ RESET	KBI1, ADC1, and TPM1 Chapters KBI1, ADC1, and TPM1 Chapters KBI1, ADC1, and TPM1 Chapters KBI1, ADC1, and TPM2 Chapters TPM2 Chapters IRQ ⁴ , and TPM2 Chapters		

Table 2-1. Pin Sharing Priority

¹ See the module section listed for information on modules that share these pins.

² Pin does not contain a clamp diode to V_{DD} and must not be driven above V_{DD}. The voltage measured on this pin when internal pullup is enabled may be as low as V_{DD} – 0.7 V. The internal gates connected to this pin are pulled to V_{DD}.

³ If both of these analog modules are enabled both will have access to the pin.

⁴ See Section 5.8, "Reset, Interrupt, and System Control Registers and Control Bits," for information on configuring the IRQ module.





Mode	PPDC	CPU, Digital Peripherals, Flash	RAM	ICS	ADC1	Regulator	I/O Pins	RTI
Stop3	0	Standby	Standby	Active	Optionally on	Active	States held	Optionally on

Table 3-2. BD	M Enabled Stop	Mode Behavior
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3.6.4 LVD Enabled in Stop Mode

The LVD system is capable of generating either an interrupt or a reset when the supply voltage drops below the LVD voltage. If the LVD is enabled in stop by setting the LVDE and the LVDSE bits, then the voltage regulator remains active during stop mode. If the user attempts to enter stop2 with the LVD enabled for stop, the MCU will instead enter stop3. Table 3-3 summarizes the behavior of the MCU in stop when the LVD is enabled.

Table 3-3. LVD Enabled Stop Mode Behavior

Mode	PPDC	CPU, Digital Peripherals, Flash	RAM	ICS	ADC1	Regulator	I/O Pins	RTI
Stop3	0	Standby	Standby	Off ¹	Optionally on	Active	States held	Optionally on

¹ ICS can be configured to run in stop3. Please see the ICS registers.

3.6.5 On-Chip Peripheral Modules in Stop Modes

When the MCU enters any stop mode, system clocks to the internal peripheral modules are stopped. Even in the exception case (ENBDM = 1), where clocks to the background debug logic continue to operate, clocks to the peripheral systems are halted to reduce power consumption. Refer to Section 3.6.1, "Stop2 Mode," and Section 3.6.2, "Stop3 Mode," for specific information on system behavior in stop modes.

Poriphoral	Mode					
Felipheral	Stop2	Stop3				
CPU	Off	Standby				
RAM	Standby	Standby				
Flash	Off	Standby				
Parallel Port Registers	Off	Standby				
ADC1	Off	Optionally On ¹				
ICS	Off	Standby				
TPM1 & TPM2	Off	Standby				
Voltage Regulator	Standby	Standby				
I/O Pins	States Held	States Held				

Table 3-4	Stop	Mode	Behavior
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Requires the asynchronous ADC clock and LVD to be enabled, else in standby.



Address	Register Name	Bit 7	6	5	4	3	2	1	Bit 0
0x1800	SRS	POR	PIN	COP	ILOP	ILAD	0	LVD	0
0x1801	SBDFR	0	0	0	0	0	0	0	BDFR
0x1802	SOPT1	COPE	COPT	STOPE	0	0	0	BKGDPE	RSTPE
0x1803	SOPT2	COPCLKS	0	0	0	0	0	0	0
0x 1804	Reserved	—	_	_	_	_	_	_	_
0x1805	Reserved	—	—	_	—	_	_	_	_
0x1806	SDIDH	REV3	REV2	REV1	REV0	ID11	ID10	ID9	ID8
0x1807	SDIDL	ID7	ID6	ID5	ID4	ID3	ID2	ID1	ID0
0x1808	SRTISC	RTIF	RTIACK	RTICLKS	RTIE	0		RTIS	
0x1809	SPMSC1	LVDF	LVDACK	LVDIE	LVDRE	LVDSE	LVDE	0 ¹	BGBE
0x180A	SPMSC2	LVWF	LVWACK	LVDV	LVWV	PPDF	PPDACK	_	PPDC
0x180B– 0x181F	Reserved	_					_		
0x1820	FCDIV	DIVLD	PRDIV8			DI	V		
0x1821	FOPT	KEYEN	FNORED	0	0	0	0	SEC01	SEC00
0x1822	Reserved	—	—	_	—	_	_	_	_
0x1823	FCNFG	0	0	KEYACC	0	0	0	0	0
0x1824	FPROT				FPS				FPDIS
0x1825	FSTAT	FCBEF	FCCF	FPVIOL	FACCERR	0	FBLANK	0	0
0x1826	FCMD				FC	MD			
0x1827– 0x183F	Reserved	_					_		
0x1840	PTAPE	0	0	PTAPE5	PTAPE4	PTAPE3	PTAPE2	PTAPE1	PTAPE0
0x1841	PTASE	0	0	PTASE5	PTASE4	PTASE3	PTASE2	PTASE1	PTASE0
0x1842	PTADS	0	0	PTADS5	PTADS4	PTADS3	PTADS2	PTADS1	PTADS0
0x1843– 0x1847	Reserved	_	_	_	_	_	_	_	_

Table 4-3. High-Page Register Summary

¹ This reserved bit must always be written to 0.

Nonvolatile flash registers, shown in Table 4-4, are located in the flash memory. These registers include an 8-byte backdoor key that optionally can be used to gain access to secure memory resources. During reset events, the contents of NVPROT and NVOPT in the nonvolatile register area of the flash memory are transferred into corresponding FPROT and FOPT working registers in the high-page registers to control security and block protection options.



5.5 Interrupts

Interrupts provide a way to save the current CPU status and registers, execute an interrupt service routine (ISR), and then restore the CPU status so processing resumes where it was before the interrupt. Other than the software interrupt (SWI), which is a program instruction, interrupts are caused by hardware events such as an edge on the IRQ pin or a timer-overflow event. The debug module can also generate an SWI under certain circumstances.

If an event occurs in an enabled interrupt source, an associated read-only status flag will become set. The CPU will not respond until and unless the local interrupt enable is a 1 to enable the interrupt. The I bit in the CCR is 0 to allow interrupts. The global interrupt mask (I bit) in the CCR is initially set after reset which masks (prevents) all maskable interrupt sources. The user program initializes the stack pointer and performs other system setup before clearing the I bit to allow the CPU to respond to interrupts.

When the CPU receives a qualified interrupt request, it completes the current instruction before responding to the interrupt. The interrupt sequence obeys the same cycle-by-cycle sequence as the SWI instruction and consists of:

- Saving the CPU registers on the stack
- Setting the I bit in the CCR to mask further interrupts
- Fetching the interrupt vector for the highest-priority interrupt that is currently pending
- Filling the instruction queue with the first three bytes of program information starting from the address fetched from the interrupt vector locations

While the CPU is responding to the interrupt, the I bit is automatically set to avoid the possibility of another interrupt interrupting the ISR itself (this is called nesting of interrupts). Normally, the I bit is restored to 0 when the CCR is restored from the value stacked on entry to the ISR. In rare cases, the I bit can be cleared inside an ISR (after clearing the status flag that generated the interrupt) so that other interrupts can be serviced without waiting for the first service routine to finish. This practice is not recommended for anyone other than the most experienced programmers because it can lead to subtle program errors that are difficult to debug.

The interrupt service routine ends with a return-from-interrupt (RTI) instruction which restores the CCR, A, X, and PC registers to their pre-interrupt values by reading the previously saved information off the stack.

NOTE

For compatibility with M68HC08 devices, the H register is not automatically saved and restored. It is good programming practice to push H onto the stack at the start of the interrupt service routine (ISR) and restore it immediately before the RTI that is used to return from the ISR.

When two or more interrupts are pending when the I bit is cleared, the highest priority source is serviced first (see Table 5-2).



Chapter 5 Resets, Interrupts, and General System Control

Vector Priority	Vector Number	Address (High:Low)	Vector Name	Module	Source	Enable	Description		
Lower	31 through 24	0xFFC0:FFC1 through 0xFFCE:FFCF			Unused Vect (available for us	Unused Vector Space (available for user program)			
	23	0xFFD0:FFD1	Vrti	Vrti System control		RTIE	Real-time interrupt		
	22	0xFFD2:FFD3	—		—	_	—		
	21	0xFFD4:FFD5	—	_	—	_	—		
	20	0xFFD6:FFD7	_		—		—		
	19	0xFFD8:FFD9	Vadc1	ADC1	COCO	AIEN	ADC1		
	18	0xFFDA:FFDB	Vkeyboard1	KBI1	KBF	KBIE	Keyboard pins		
	17	0xFFDC:FFDD	_		—		—		
	16	0xFFDE:FFDF	_		—		—		
	15	0xFFE0:FFE1	—	_	—	—	—		
	14	0xFFE2:FFE3	_		—		—		
	13	0xFFE4:FFE5	—	_	—	—	—		
	12	0xFFE6:FFE7	—		—	—	—		
	11	0xFFE8:FFE9	—		—	_	—		
	10	0xFFEA:FFEB	Vtpm2ovf	TPM2	TOF	TOIE	TPM2 overflow		
	9	0xFFEC:FFED	—	_	—	—	—		
	8	0xFFEE:FFEF	Vtpm2ch0	TPM2	CH0F	CH0IE	TPM2 channel 0		
	7	0xFFF0:FFF1	Vtpm1ovf	TPM1	TOF	TOIE	TPM1 overflow		
	6	0xFFF2:FFF3	Vtpm1ch1	TPM1	CH1F	CH1IE	TPM1 channel 1		
	5	0xFFF4:FFF5	Vtpm1ch0	TPM1	CH0F	CH0IE	TPM1 channel 0		
	4	0xFFF6:FFF7	_		—		—		
	3	0xFFF8:FFF9	Virq	IRQ	IRRQF	IRQIE	IRQ pin		
	2	0xFFFA:FFFB	Vlvd	System control	LVDF	LVDIE	Low voltage detect		
	1	0xFFFC:FFFD	Vswi	CPU	SWI Instruction	_	Software interrupt		
▼ Higher	0	0xFFFE:FFFF	Vreset	System control	COP LVD RESET pin Illegal opcode Illegal address POR	COPE LVDRE RSTPE — — —	Watchdog timer Low-voltage detect External pin Illegal opcode Illegal address power-on-reset		

Table 5-2. Vector Summary

5.6 Low-Voltage Detect (LVD) System

The MC9S08QD4 series includes a system to protect against low voltage conditions in order to protect memory contents and control MCU system states during supply voltage variations. The system is comprised of a power-on reset (POR) circuit and an LVD circuit with a user selectable trip voltage, either high (V_{LVDH}) or low (V_{LVDL}). The LVD circuit is enabled when LVDE in SPMSC1 is high and the trip voltage is selected by LVDV in SPMSC2. The LVD is disabled upon entering any of the stop modes unless LVDSE is set in SPMSC1. If LVDSE and LVDE are both set, then the MCU cannot enter stop1 or stop2, and the current consumption in stop3 with the LVD enabled will be greater.



Chapter 6 Parallel Input/Output Control

This section explains software controls related to parallel input/output (I/O) and pin control. The MC9S08QD4 series has one parallel I/O port which include a total of 4 I/O pins, one output-only pin, and one input-only pin. See Section Chapter 2, "External Signal Description," for more information about pin assignments and external hardware considerations of these pins.

All of these I/O pins are shared with on-chip peripheral functions as shown in Table 2-1. The peripheral modules have priority over the I/Os so that when a peripheral is enabled, the I/O functions associated with the shared pins are disabled. After reset, the shared peripheral functions are disabled so that the pins are controlled by the I/O. All of the I/Os are configured as inputs (PTxDDn = 0) with pullup devices disabled (PTxPEn = 0), except for output-only pin PTA4 which defaults to BKGD/MS pin.

NOTE

Not all general-purpose I/O pins are available on all packages. To avoid extra current drain from floating input pins, the user's reset initialization routine in the application program must either enable on-chip pullup devices or change the direction of unconnected pins to outputs so the pins do not float.

6.1 Port Data and Data Direction

Reading and writing of parallel I/Os is performed through the port data registers. The direction, either input or output, is controlled through the port data direction registers. The parallel I/O port function for an individual pin is illustrated in the block diagram shown in Figure 6-1.



6.4.2.1 Port A Internal Pullup Enable (PTAPE)

An internal pullup device can be enabled for each port pin by setting the corresponding bit in the pullup enable register (PTAPEn). The pullup device is disabled if the pin is configured as an output by the parallel I/O control logic or any shared peripheral function regardless of the state of the corresponding pullup enable register bit. The pullup device is also disabled if the pin is controlled by an analog function.

_	7	6	5	4	3	2	1	0
R	0	0		ρταρεμ ¹	ρτάρες	ΡΤΔΡΕ2		ρτάρεο
W								
Reset:	0	0	0	0	0	0	0	0

¹ PTAPE4 has no effect on the output-only PTA4 pin.

Figure 6-4. Internal Pullup Enable for Port A Register (PTAPE)

Table 6-3. PTAPE Register Field Descriptions

Field	Description
5:0	Internal Pullup Enable for Port A Bits — Each of these control bits determines if the internal pullup device is
PTAPE[5:0]	enabled for the associated PTA pin. For port A pins that are configured as outputs, these bits have no effect and
	the internal pullup devices are disabled.
	0 Internal pullup device disabled for port A bit n.
	1 Internal pullup device enabled for port A bit n.

6.4.2.2 Port A Slew Rate Enable (PTASE)

Slew rate control can be enabled for each port pin by setting the corresponding bit in the slew rate control register (PTASEn). When enabled, slew control limits the rate at which an output can transition in order to reduce EMC emissions. Slew rate control has no effect on pins which are configured as inputs.

	7	6	5	4	3	2	1	0
R	0	0		DTAGEA	DTAGES	DTAGE2		DTASEO
w			T IAGES		TIAGES	TIAGEZ	TIAGET	TIAGEO
Reset:	0	0	1	1	1	1	1	1

¹ PTASE5 has no effect on the input-only PTA5 pin.

Figure 6-5. Slew Rate Enable for Port A Register (PTASE)

Table 6-4. PTASE Register Field Descriptions

Field	Description
5:0 PTASE[5:0]	 Output Slew Rate Enable for Port A Bits — Each of these control bits determines if the output slew rate control is enabled for the associated PTA pin. For port A pins that are configured as inputs, these bits have no effect. Output slew rate control disabled for port A bit n. Output slew rate control enabled for port A bit n.

MC9S08QD4 Series MCU Data Sheet, Rev. 6



8.2.1 Analog Power (V_{DDAD})

The ADC analog portion uses V_{DDAD} as its power connection. In some packages, V_{DDAD} is connected internally to V_{DD} . If externally available, connect the V_{DDAD} pin to the same voltage potential as V_{DD} . External filtering may be necessary to ensure clean V_{DDAD} for good results.

8.2.2 Analog Ground (V_{SSAD})

The ADC analog portion uses V_{SSAD} as its ground connection. In some packages, V_{SSAD} is connected internally to V_{SS} . If externally available, connect the V_{SSAD} pin to the same voltage potential as V_{SS} .

8.2.3 Voltage Reference High (V_{REFH})

 V_{REFH} is the high reference voltage for the converter. In some packages, V_{REFH} is connected internally to V_{DDAD} . If externally available, V_{REFH} may be connected to the same potential as V_{DDAD} , or may be driven by an external source that is between the minimum V_{DDAD} spec and the V_{DDAD} potential (V_{REFH} must never exceed V_{DDAD}).

8.2.4 Voltage Reference Low (V_{REFL})

 V_{REFL} is the low reference voltage for the converter. In some packages, V_{REFL} is connected internally to V_{SSAD} . If externally available, connect the V_{REFL} pin to the same voltage potential as V_{SSAD} .

8.2.5 Analog Channel Inputs (ADx)

The ADC module supports up to 28 separate analog inputs. An input is selected for conversion through the ADCH channel select bits.

8.3 **Register Definition**

These memory mapped registers control and monitor operation of the ADC:

- Status and control register, ADCSC1
- Status and control register, ADCSC2
- Data result registers, ADCRH and ADCRL
- Compare value registers, ADCCVH and ADCCVL
- Configuration register, ADCCFG
- Pin enable registers, APCTL1, APCTL2, APCTL3

8.3.1 Status and Control Register 1 (ADCSC1)

This section describes the function of the ADC status and control register (ADCSC1). Writing ADCSC1 aborts the current conversion and initiates a new conversion (if the ADCH bits are equal to a value other than all 1s).



Field	Description
5 ACFE	 Compare Function Enable — ACFE is used to enable the compare function. 0 Compare function disabled 1 Compare function enabled
4 ACFGT	 Compare Function Greater Than Enable — ACFGT is used to configure the compare function to trigger when the result of the conversion of the input being monitored is greater than or equal to the compare value. The compare function defaults to triggering when the result of the compare of the input being monitored is less than the compare value. 0 Compare triggers when input is less than compare level 1 Compare triggers when input is greater than or equal to compare level

Table 8-4. ADCSC2 Register Field Descriptions (continued)

8.3.3 Data Result High Register (ADCRH)

ADCRH contains the upper two bits of the result of a 10-bit conversion. When configured for 8-bit conversions both ADR8 and ADR9 are equal to zero. ADCRH is updated each time a conversion completes except when automatic compare is enabled and the compare condition is not met. In 10-bit MODE, reading ADCRH prevents the ADC from transferring subsequent conversion results into the result registers until ADCRL is read. If ADCRL is not read until after the next conversion is completed, then the intermediate conversion result will be lost. In 8-bit mode there is no interlocking with ADCRL. In the case that the MODE bits are changed, any data in ADCRH becomes invalid.



Figure 8-6. Data Result High Register (ADCRH)

8.3.4 Data Result Low Register (ADCRL)

ADCRL contains the lower eight bits of the result of a 10-bit conversion, and all eight bits of an 8-bit conversion. This register is updated each time a conversion completes except when automatic compare is enabled and the compare condition is not met. In 10-bit mode, reading ADCRH prevents the ADC from transferring subsequent conversion results into the result registers until ADCRL is read. If ADCRL is not read until the after next conversion is completed, then the intermediate conversion results will be lost. In 8-bit mode, there is no interlocking with ADCRH. In the case that the MODE bits are changed, any data in ADCRL becomes invalid.



Table 8-8	3. Input	Clock	Select
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ADICLK	Selected Clock Source
00	Bus clock
01	Bus clock divided by 2
10	Alternate clock (ALTCLK)
11	Asynchronous clock (ADACK)

Pin Control 1 Register (APCTL1) 8.3.8

The pin control registers are used to disable the I/O port control of MCU pins used as analog inputs. APCTL1 is used to control the pins associated with channels 0–7 of the ADC module.



Figure 8-11. Pin Control 1 Register (APCTL1)

Table 8-9. APCILI Register Field Descriptions		
Field	Description	
7 ADPC7	 ADC Pin Control 7 — ADPC7 is used to control the pin associated with channel AD7. 0 AD7 pin I/O control enabled 1 AD7 pin I/O control disabled 	
6 ADPC6	 ADC Pin Control 6 — ADPC6 is used to control the pin associated with channel AD6. 0 AD6 pin I/O control enabled 1 AD6 pin I/O control disabled 	
5 ADPC5	 ADC Pin Control 5 — ADPC5 is used to control the pin associated with channel AD5. 0 AD5 pin I/O control enabled 1 AD5 pin I/O control disabled 	
4 ADPC4	 ADC Pin Control 4 — ADPC4 is used to control the pin associated with channel AD4. 0 AD4 pin I/O control enabled 1 AD4 pin I/O control disabled 	

Table 9.0 ABCTI 1 Degister Field Descriptions

	1 AD4 pin I/O control disabled
3 ADPC3	 ADC Pin Control 3 — ADPC3 is used to control the pin associated with channel AD3. 0 AD3 pin I/O control enabled 1 AD3 pin I/O control disabled
2 ADPC2	 ADC Pin Control 2 — ADPC2 is used to control the pin associated with channel AD2. 0 AD2 pin I/O control enabled 1 AD2 pin I/O control disabled



Field	Description
1 ADPC1	 ADC Pin Control 1 — ADPC1 is used to control the pin associated with channel AD1. 0 AD1 pin I/O control enabled 1 AD1 pin I/O control disabled
0 ADPC0	 ADC Pin Control 0 — ADPC0 is used to control the pin associated with channel AD0. 0 AD0 pin I/O control enabled 1 AD0 pin I/O control disabled

Table 8-9. APCTL1 Register Field Descriptions (continued)

8.3.9 Pin Control 2 Register (APCTL2)

APCTL2 is used to control channels 8–15 of the ADC module.



Figure 8-12. Pin Control 2 Register (APCTL2)

Table 8-10. APCTL2 Register Field Descriptions

Field	Description
7 ADPC15	 ADC Pin Control 15 — ADPC15 is used to control the pin associated with channel AD15. 0 AD15 pin I/O control enabled 1 AD15 pin I/O control disabled
6 ADPC14	 ADC Pin Control 14 — ADPC14 is used to control the pin associated with channel AD14. 0 AD14 pin I/O control enabled 1 AD14 pin I/O control disabled
5 ADPC13	 ADC Pin Control 13 — ADPC13 is used to control the pin associated with channel AD13. 0 AD13 pin I/O control enabled 1 AD13 pin I/O control disabled
4 ADPC12	 ADC Pin Control 12 — ADPC12 is used to control the pin associated with channel AD12. 0 AD12 pin I/O control enabled 1 AD12 pin I/O control disabled
3 ADPC11	 ADC Pin Control 11 — ADPC11 is used to control the pin associated with channel AD11. 0 AD11 pin I/O control enabled 1 AD11 pin I/O control disabled
2 ADPC10	 ADC Pin Control 10 — ADPC10 is used to control the pin associated with channel AD10. 0 AD10 pin I/O control enabled 1 AD10 pin I/O control disabled



9.1.2 Features

Key features of the ICS module are:

- Frequency-locked loop (FLL) is trimmable for accuracy
 - 0.2% resolution using internal 32 kHz reference
 - 2% deviation over voltage and temperature using internal 32 kHz reference
- Internal or external reference clocks up to 5 MHz can be used to control the FLL
 - 3 bit select for reference divider is provided
- Internal reference clock has 9 trim bits available
- Internal or external reference clocks can be selected as the clock source for the MCU
- Whichever clock is selected as the source can be divided down
 - 2 bit select for clock divider is provided
 - Allowable dividers are: 1, 2, 4, 8
 - BDC clock is provided as a constant divide by 2 of the DCO output
- Control signals for a low power oscillator as the external reference clock are provided — HGO, RANGE, EREFS, ERCLKEN, EREFSTEN
- FLL engaged internal mode is automatically selected out of reset

9.1.3 Modes of Operation

There are seven modes of operation for the ICS: FEI, FEE, FBI, FBILP, FBE, FBELP, and stop.

9.1.3.1 FLL Engaged Internal (FEI)

In FLL engaged internal mode, which is the default mode, the ICS supplies a clock derived from the FLL which is controlled by the internal reference clock. The BDC clock is supplied from the FLL.

9.1.3.2 FLL Engaged External (FEE)

In FLL engaged external mode, the ICS supplies a clock derived from the FLL which is controlled by an external reference clock. The BDC clock is supplied from the FLL.

9.1.3.3 FLL Bypassed Internal (FBI)

In FLL bypassed internal mode, the FLL is enabled and controlled by the internal reference clock, but is bypassed. The ICS supplies a clock derived from the internal reference clock. The BDC clock is supplied from the FLL.

9.1.3.4 FLL Bypassed Internal Low Power (FBILP)

In FLL bypassed internal low power mode, the FLL is disabled and bypassed, and the ICS supplies a clock derived from the internal reference clock. The BDC clock is not available.



Internal Clock Source (S08ICSV1)

times the filter frequency, as selected by the RDIV bits, so that the ICSLCLK will be available for BDC communications, and the external reference clock is enabled.

9.4.1.6 FLL Bypassed External Low Power (FBELP)

The FLL bypassed external low power (FBELP) mode is entered when all the following conditions occur:

- CLKS bits are written to 10.
- IREFS bit is written to 0.
- BDM mode is not active and LP bit is written to 1.

In FLL bypassed external low power mode, the ICSOUT clock is derived from the external reference clock and the FLL is disabled. The ICSLCLK will be not be available for BDC communications. The external reference clock is enabled.

9.4.1.7 Stop

Stop mode is entered whenever the MCU enters a STOP state. In this mode, all ICS clock signals are static except in the following cases:

ICSIRCLK will be active in stop mode when all the following conditions occur:

- IRCLKEN bit is written to 1
- IREFSTEN bit is written to 1

ICSERCLK will be active in stop mode when all the following conditions occur:

- ERCLKEN bit is written to 1
- EREFSTEN bit is written to 1

9.4.2 Mode Switching

When switching between FLL engaged internal (FEI) and FLL engaged external (FEE) modes the IREFS bit can be changed at anytime, but the RDIV bits must be changed simultaneously so that the resulting frequency stays in the range of 31.25 kHz to 39.0625 kHz. After a change in the IREFS value the FLL will begin locking again after a few full cycles of the resulting divided reference frequency.

The CLKS bits can also be changed at anytime, but the RDIV bits must be changed simultaneously so that the resulting frequency stays in the range of 31.25 kHz to 39.0625 kHz. The actual switch to the newly selected clock will not occur until after a few full cycles of the new clock. If the newly selected clock is not available, the previous clock will remain selected.

9.4.3 Bus Frequency Divider

The BDIV bits can be changed at anytime and the actual switch to the new frequency will occur immediately.





Figure 10-3. KBI Status and Control Register

Table 10-2. KBISC Register Field Descriptions

Field	Description	
7:4	Unused register bits, always read 0.	
3 KBF	 Keyboard Interrupt Flag — KBF indicates when a keyboard interrupt is detected. Writes have no effect on KBF. No keyboard interrupt detected. Keyboard interrupt detected. 	
2 KBACK	Keyboard Acknowledge — Writing a 1 to KBACK is part of the flag clearing mechanism. KBACK always reads as 0.	
1 KBIE	 Keyboard Interrupt Enable — KBIE determines whether a keyboard interrupt is requested. Keyboard interrupt request not enabled. Keyboard interrupt request enabled. 	
0 KBMOD	 Keyboard Detection Mode — KBMOD (along with the KBEDG bits) controls the detection mode of the keyboard interrupt pins.0Keyboard detects edges only. Keyboard detects both edges and levels. 	

10.3.2 KBI Pin Enable Register (KBIPE)

KBIPE contains the pin enable control bits.



Figure 10-4. KBI Pin Enable Register

Table 10-3. KBIPE Register Field Descriptions

Field	Description
7:0 KBIPEn	 Keyboard Pin Enables — Each of the KBIPEn bits enable the corresponding keyboard interrupt pin. 0 Pin not enabled as keyboard interrupt. 1 Pin enabled as keyboard interrupt.

10.3.3 KBI Edge Select Register (KBIES)

KBIES contains the edge select control bits.

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CLKSB:CLKSA	TPM Clock Source to Prescaler Input
0:0	No clock selected (TPMx disabled)
0:1	Bus rate clock (BUSCLK)
1:0	Fixed system clock (XCLK)
1:1	External source (TPMxCLK) ^{1,2}

Table 11-2. TPM Clock Source Selection

¹ The maximum frequency that is allowed as an external clock is one-fourth of the bus frequency.

² If the external clock input is shared with channel n and is selected as the TPM clock source, the corresponding ELSnB:ELSnA control bits must be set to 0:0 so channel n does not try to use the same pin for a conflicting function.

PS2:PS1:PS0	TPM Clock Source Divided-By	
0:0:0	1	
0:0:1	2	
0:1:0	4	
0:1:1	8	
1:0:0	16	
1:0:1	32	
1:1:0	64	
1:1:1	128	

Table 11-3. Prescale Divisor Selection

11.3.2 Timer Counter Registers (TPMxCNTH:TPMxCNTL)

The two read-only TPM counter registers contain the high and low bytes of the value in the TPM counter. Reading either byte (TPMxCNTH or TPMxCNTL) latches the contents of both bytes into a buffer where they remain latched until the other byte is read. This allows coherent 16-bit reads in either order. The coherency mechanism is automatically restarted by an MCU reset, a write of any value to TPMxCNTH or TPMxCNTL, or any write to the timer status/control register (TPMxSC).

Reset clears the TPM counter registers.



transferred to the corresponding timer channel registers only after both 8-bit bytes of a 16-bit register have been written and the timer counter overflows (reverses direction from up-counting to down-counting at the end of the terminal count in the modulus register). This TPMxCNT overflow requirement only applies to PWM channels, not output compares.

Optionally, when TPMxCNTH:TPMxCNTL = TPMxMODH:TPMxMODL, the TPM can generate a TOF interrupt at the end of this count. The user can choose to reload any number of the PWM buffers, and they will all update simultaneously at the start of a new period.

Writing to TPMxSC cancels any values written to TPMxMODH and/or TPMxMODL and resets the coherency mechanism for the modulo registers. Writing to TPMxCnSC cancels any values written to the channel value registers and resets the coherency mechanism for TPMxCnVH:TPMxCnVL.

11.5 TPM Interrupts

The TPM generates an optional interrupt for the main counter overflow and an interrupt for each channel. The meaning of channel interrupts depends on the mode of operation for each channel. If the channel is configured for input capture, the interrupt flag is set each time the selected input capture edge is recognized. If the channel is configured for output compare or PWM modes, the interrupt flag is set each time the main timer counter matches the value in the 16-bit channel value register. See the Resets, Interrupts, and System Configuration chapter for absolute interrupt vector addresses, priority, and local interrupt mask control bits.

For each interrupt source in the TPM, a flag bit is set on recognition of the interrupt condition such as timer overflow, channel input capture, or output compare events. This flag may be read (polled) by software to verify that the action has occurred, or an associated enable bit (TOIE or CHnIE) can be set to enable hardware interrupt generation. While the interrupt enable bit is set, a static interrupt will be generated whenever the associated interrupt flag equals 1. It is the responsibility of user software to perform a sequence of steps to clear the interrupt flag before returning from the interrupt service routine.

11.5.1 Clearing Timer Interrupt Flags

TPM interrupt flags are cleared by a 2-step process that includes a read of the flag bit while it is set (1) followed by a write of 0 to the bit. If a new event is detected between these two steps, the sequence is reset and the interrupt flag remains set after the second step to avoid the possibility of missing the new event.

11.5.2 Timer Overflow Interrupt Description

The conditions that cause TOF to become set depend on the counting mode (up or up/down). In up-counting mode, the 16-bit timer counter counts from 0x0000 through 0xFFFF and overflows to 0x0000 on the next counting clock. TOF becomes set at the transition from 0xFFFF to 0x0000. When a modulus limit is set, TOF becomes set at the transition from the value set in the modulus register to 0x0000. When the counter is operating in up-/down-counting mode, the TOF flag gets set as the counter changes direction at the transition from the value set in the modulus register and the next lower count value. This corresponds to the end of a PWM period. (The 0x0000 count value corresponds to the center of a period.)



Characteristic	Conditions	Symb	Min	Typ ¹	Мах	Unit	Comment
Zero-Scale Error	10 bit mode	E _{ZS}	0	±1.5	±3.1	LSB	V _{ADIN} = V _{SSA}
	8 bit mode		0	±0.5	±0.7		
Full-Scale Error	10 bit mode	E _{FS}	0	±1.0	±1.5	LSB	V _{ADIN} = V _{DDA}
	8 bit mode		0	±0.5	±0.5		
Quantization Error	10 bit mode	EQ	—	_	±0.5	LSB	8 bit mode is not truncated

Table A-10. ADC Characteristics (continued)

¹ Typical values assume V_{DDAD} = 5.0 V, Temp = 25°C, f_{ADCK}=1.0 MHz unless otherwise stated. Typical values are for reference only and are not tested in production.

² At 4 MHz, for maximum frequency, use proportionally lower source impedance.

A.10 Flash Specifications

This section provides details about program/erase times and program-erase endurance for the flash memory.

Program and erase operations do not require any special power sources other than the normal V_{DD} supply. For more detailed information about program/erase operations, see the Memory section.

Characteristic	Symbol	Min	Typical	Max	Unit
Supply voltage for program/erase -40°C to 125°C	V _{prog/erase}	2.7		5.5	V
Supply voltage for read operation	V _{Read}	2.7		5.5	V
Internal FCLK frequency ¹	f _{FCLK}	150		200	kHz
Internal FCLK period (1/FCLK)	t _{Fcyc}	5		6.67	μs
Byte program time (random location) ⁽²⁾	t _{prog}	9		t _{Fcyc}	
Byte program time (burst mode) ⁽²⁾	ne (burst mode) ⁽²⁾ t _{Burst} 4			t _{Fcyc}	
Page erase time ²	t _{Page}	4000		t _{Fcyc}	
Mass erase time ⁽²⁾	t _{Mass}	20,000		t _{Fcyc}	
Program/erase endurance ³ T_L to $T_H = -40^{\circ}C$ to + 125°C $T = 25^{\circ}C$	-	10,000	 100,000		cycles
Data retention ⁴	t _{D_ret}	15	100	_	years

Table A-11. Flash Characteristics

¹ The frequency of this clock is controlled by a software setting.

² These values are hardware state machine controlled. User code does not need to count cycles. This information supplied for calculating approximate time to program and erase.

- ³ Typical endurance for flash was evaluated for this product family on the 9S12Dx64. For additional information on how Freescale defines typical endurance, please refer to Engineering Bulletin EB619/D, *Typical Endurance for Nonvolatile Memory*.
- ⁴ Typical data retention values are based on intrinsic capability of the technology measured at high temperature and de-rated to 25°C using the Arrhenius equation. For additional information on how Freescale defines typical data retention, please refer to Engineering Bulletin EB618/D, *Typical Data Retention for Nonvolatile Memory.*



NOTES:

- 1. DIMENSIONS ARE IN MILLIMETERS.
- 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- A DIMENSION DOES NOT INCLUDE MOLD PROTRUSION. MAXIMUM MOLD PROTRUSION 0.15 PER SIDE.
- A. DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 TOTAL IN EXCESS OF THE DIMENSION AT MAXIMUM MATERIAL CONDITION.

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